

Abstracts

MEMS designed for tunable capacitors

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A new tunable capacitor based on a standard microelectromechanical systems (MEMS) technology has been demonstrated. Its unique feature was the use of thermal actuators as indirect drives to change air gap from 2 to 0.2 μm for high-Q MM-wave capacitors. Such a drive scheme achieved a sub- μm controllability. The insertion loss of a polysilicon MEMS capacitor was measured to be -4dB at 40 GHz. Such a loss would have been better than -1 dB if the polysilicon were coated with metal.

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